S	earch	Notes	

_	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/720,074	LIN ET AL.	
	Examiner	Art Unit	
	JEAN B. FLEURANTIN	2162	

SEARCHED			
Class	Subclass	Date	Examiner
707	1-10	4/25/2006	JBF
707	100-104.1	4/25/2006	JBF
707	200-206	4/25/2006	JBF
709	225	4/25/2006	JBF
713	152	4/25/2006	JBF
713	164	4/25/2006	JBF
713	166	4/25/2006	JBF
726	1-2	4/25/2006	JBF
726	12	4/25/2006	JBF

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
WEST (US PG PUB, US PT, EPO, JPO, DERWENT AND IBM TDB)	4/25/2006	JBF
707/CCLS AND 709/CCLS AND 713/CCLS AND 726/CCLS	4/25/2006	JBF
INVENTOR(S0 SEARCH AND REVIEWED ALL RELATED APPLICATION FOR POSSIBLE DOUBLE PATENTING	4/25/2006	JBF
CONSULTED - TQAS - 101 HELP PANEL M. BOOKDINDER	4/28/2006	JBF